



**Data Sheet** 

February 2003

**Features** 

- 2,048 × 512 and 512 x 512 switching among backplane and local streams
- Rate conversion between 2.048, 4.096 and 8.192Mb/s
- Optional sub-rate switch configuration for 2.048 Mb/s streams
- Per-channel variable or constant throughput delay
- · Compatible to HMVIP and H.100 specifications
- Automatic frame offset delay measurement
- Per-stream frame delay offset programming
- · Per-channel message mode
- · Per-channel direction control
- Per-channel high impedance output control
- · Non-multiplexed microprocessor interface
- · Connection memory block programming
- 3.3V local I/O with 5V tolerant inputs and TTL-compatible outputs
- IEEE-1149.1 (JTAG) Test Port

## **Applications**

- Medium and large switching platforms
- CTI application
- Voice/data multiplexer
- Support ST-BUS, HMVIP and H.100 interfaces

## **Ordering Information**

MT90863AL 128 Pin MQFP MT90863AG 144 Pin BGA

-40°C to +85°C

## **Description**

The MT90863 Rate Conversion Switch provides switching capacities of  $2,048 \times 512$  channels between backplane and local streams, and  $512 \times 512$  channels for local streams. The connected serial inputs and outputs may have 32, 64 and 128 64kb/s channels per frame with data rates of 2.048Mb/s, 4.096Mb/s and 8.192Mb/s respectively.

The MT90863 also offers a sub-rate switching configuration which allows 2-bit wide 16kb/s data channels to be switched within the device.

The device has features (such as: message mode; input and output offset delay; direction control; and, high impedance output control) that are programmable on per-stream or per-channel basis.

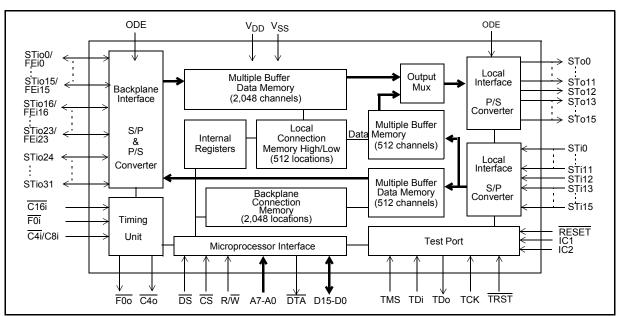


Figure 1 - Functional Block Diagram

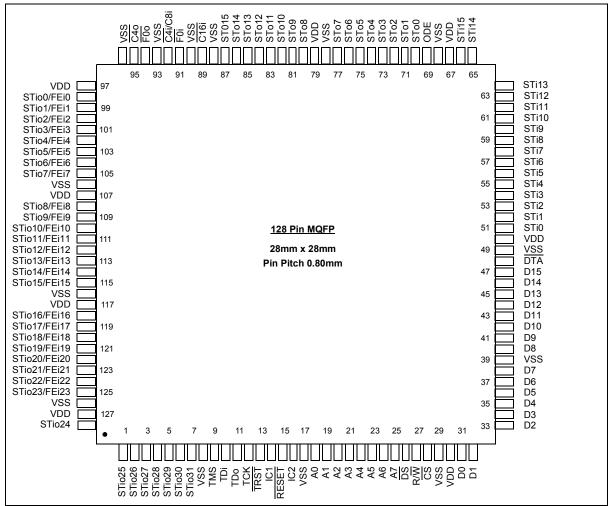


Figure 2 - MQFP Pin Connections

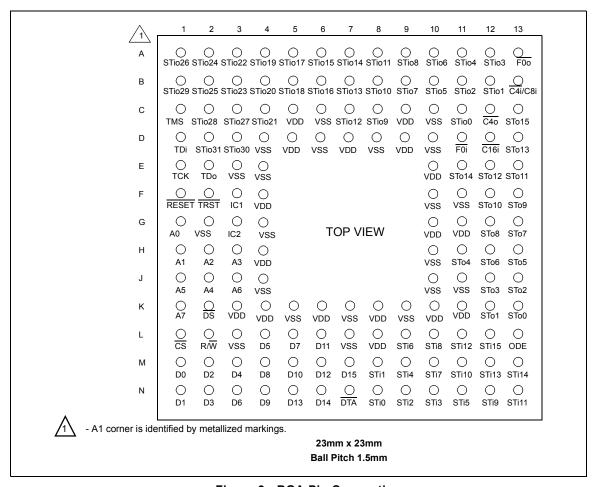


Figure 3 - BGA Pin Connections

# **Pin Description**

128 MQFP Pin#	144 BGA Pin#	Name	Description
30,50,67, 79,97,107, 117,127	C5,C9,D5,D7, D9,E10,F4,G10 ,G11,H4, K3,K4,K6,K8 K10,K11,L8	V <sub>DD</sub>	+3.3 Volt Power Supply
8,17,29,39, 49,68,78,8 8,90,93,96, 106, 116,126	C6,C10,D4,D6, D8,D10,E3,E4, F10,F11,G2, G4,H10,J4, J10,J11,K5 K7,K9,L3,L7	$V_{ss}$	Ground
89	D12	C16i	Master Clock (5V Tolerant Input): Serial clock for shifting data in/out on the serial streams. This pin accepts a 16.384 MHz clock.
91	D11	<del>F0</del> i	Master Frame Pulse (5V Tolerant Input): In ST-BUS mode, this input accepts a 61ns wide negative frame pulse. In CT Bus mode, it accepts a 122ns wide negative frame pulse. In HMVIP mode, it accepts a 244ns wide negative frame pulse.
92	B13	C4i/C8i	HMVIP/CT Bus Clock (5V Tolerant Input): When HMVIP mode is enabled, this pin accepts a 4.096MHz clock for HMVIP frame pulse alignment. When CT Bus mode is enabled, it accepts a 8.192MHz clock for CT frame pulse alignment.
94	A13	F0o	Frame Pulse (5V Tolerant Output): A 244ns wide negative frame pulse that is phase locked to the master frame pulse (F0i).
95	C12	C40	C4 Clock (5V Tolerant Out <u>put):</u> A 4.096MHz clock that is phase locked to the master clock (C16i).
98-105, 108-115	C11, B12, B11, A12, A11, B10, A10, B9, A9, C8, B8, A8, C7, B7, A7, A6,	STio0 - 15 FEi0 - 15	Serial Input Streams 0 to 15 / Frame Evaluation Inputs 0 to 15 (5V Tolerant I/O). In 2Mb/s and HMVIP modes, these pins accept serial TDM data streams at 2.048 Mb/s with 32 channels per stream. In 4Mb/s or 8Mb/s mode, these pins accept serial TDM data streams at 4.096 or 8.192 Mb/s with 64 or 128 channels per stream respectively. In Frame Evaluation Mode (FEM), they are frame evaluation inputs.
118-125	B6, A5, B5, A4, B4, C4, A3, B3	STio16 - 23 FEi16 - 23	Serial Input Streams 16 to 23 (5V Tolerant I/O). In 2Mb/s or 4Mb/s mode, these pins accept serial TDM data streams at 2.048 or 4.096 Mb/s with 32 or 64 channels per stream respectively. In HMVIP mode, these pins have a data rate of 8.192Mb/s with 128 channels per stream. In Frame Evaluation Mode (FEM), they are frame evaluation inputs.
128, 1-7	A2, B2, A1, C3, C2, B1, D3, D2	STio24 - 31	Serial Input Streams 24 to 31 (5V Tolerant I/O). These pins are only used for 2Mb/s or 4Mb/s mode. They accept serial TDM data streams at 2.048 or 4.096 Mb/s with 32 or 64 channels per stream respectively.
9	C1	TMS	<b>Test Mode Select (3.3V Input with internal pull-up):</b> JTAG signal that controls the state transitions of the TAP controller.
10	D1	TDi	Test Serial Data In (3.3V Input with internal pull-up): JTAG serial test instructions and data are shifted in on this pin.

# **Pin Description (continued)**

128 MQFP Pin#	144 BGA Pin#	Name	Description
11	E2	TDo	<b>Test Serial Data Out (3.3V Output):</b> JTAG serial data is output on this pin on the falling edge of TCK. This pin is held in a high impedance state when JTAG scan is not enabled.
12	E1	TCK	<b>Test Clock (5V Tolerant Input):</b> Provides the clock to the JTAG test logic.
13	F2	TRST	<b>Test Reset (3.3 V Input with internal pull-up):</b> Asynchronously initializes the JTAG TAP controller by putting it in the Test-Logic-Reset state. This pin should be pulsed low on power-up, or held low continuously, to ensure that the MT90863 is in the normal operation mode.
14	F3	IC1	Internal Connection 1 (3.3V Input with internal pull-down): Connect to $V_{SS}$ for normal operation.
15	F1	RESET	<b>Device Reset (5V Tolerant Input):</b> This input (active LOW) puts the MT90863 in its reset state. This clears the device's internal counters and registers.
16	G3	IC2	Internal Connection 2 (3.3V Input): Connect to V <sub>SS</sub> for normal operation.
18-25	G1, H1, H2, H3, J2, J1,J3, K1	A0 - A7	Address 0 - 7 (5V Tolerant Input): These lines provide the A0 to A7 address lines to the internal memories.
26	K2	DS	Data Strobe (5V Tolerant Input): This active low input works in conjunction with $\overline{\text{CS}}$ to enable the read and write operations.
27	L2	R/W	Read/Write (5V Tolerant Input): This input controls the direction of the data bus lines (D0-D15) during a microprocessor access.
28	L1	CS	Chip Select (5V Tolerant Input): Active low input used by a microprocessor to activate the microprocessor port.
31-38, 40-47	M1, N1, M2, N2, M3, L4, N3, L5, M4, N4, M5, L6, M6, N5, N6, M7,	D0 - 7, D8 - D15	Data Bus 0 -15 (5V Tolerant I/O): These pins form the 16-bit data bus of the microprocessor port.
48	N7	DTA	Data Transfer Acknowledgment (5V Tolerant Three-state Output): This active low output indicates that a data bus transfer is complete. A pull-up resistor is required to hold a HIGH level when the pin is tri-stated.
51-54	N8, M8, N9, N10	STi0 - 3	Serial Input Streams 0 to 3 (5V Tolerant Inputs): In 2Mb/s or Subrate Switching mode, these inputs accept data rates of 2.048 Mb/s with 32 channels per stream. In 8Mb/s mode, these inputs accept data rates of 8.192 Mb/s with 128 channels per stream.
55-62	M9, N11, L9, M10, L10, N12, M11, N13	STi4 - 11	Serial Input Streams 4 to 11 (5V Tolerant Inputs): In 2Mb/s or Sub-rate Switching mode, these inputs accept data rates of 2.048Mb/s with 32 channels per stream.

## **Pin Description (continued)**

128 MQFP Pin#	144 BGA Pin#	Name	Description
63	L11	STi12	Serial Input Streams 12 (5V Tolerant Input): In 2Mb/s mode, this input accepts data rate of 2.048Mb/s with 32 channels per stream respectively. In Sub-rate Switching mode, this pin accepts 2.048Mb/s with 128 channels per stream for Sub-rate switching application.
64-66	M12, M13, L12	STi13 - 15	Serial Input Streams 13 to 15 (5V Tolerant Inputs): In 2Mb/s mode, these inputs accept a data rate of 2.048Mb/s with 32 channels per stream.
69	L13	ODE	Output Drive Enable (5V Tolerant Input): This is the output enable control for the STo0 to STo15 serial outputs and STio0 to STio31 serial bidirectional outputs.
70-73	K13, K12, J13, J12	STo0 - 3	Serial Output Streams 0 to 3 (5V Tolerant Three-state Outputs): In 2Mb/s or Sub-rate Switching mode, these outputs have data rates of 2.048 Mb/s with 32 channels per stream respectively. In 8Mb/s mode, these outputs have data rates of 8.192 Mb/s with 128 channels per stream
74-77, 80-83	H11, H13, H12, G13, G12, F13, F12, E13	STo4 - 7, STo8 - 11	Serial Output Streams 4 to 11 (5V Tolerant Three-state Outputs): In 2Mb/s or Sub-rate Switching mode, these outputs have data rates of 2.048Mb/s with 32 channels per stream
84	E12	STo12	Serial Output Streams 12 (5V Tolerant Three-state Output): In 2Mb/s mode, this output has data rate of 2.048Mb/s with 32 channels per stream. In Sub-rate Switching mode, this pin has data rate of 2.048Mb/s with 128 channels per stream for Sub-rate switching application.
85-87	D13, E11, C13	STo13 - 15	Serial Output Streams 13 to 15 (5V Tolerant Three-state Outputs): In 2Mb/s mode, these outputs have a data rate of 2.048Mb/s with 32 channels per stream.

## 1.0 Device Overview

The Rate conversion Switch (MT90863) can switch up to  $2,048 \times 512$  channels while also providing a rate conversion capability. It is designed to switch 64 kb/s PCM or N X 64 kb/s data between the backplane and local interfaces. When the device is in the sub-rate switching mode, 2-bit wide 16 kb/s data channels can be switched within the device. The device maintains frame integrity in data applications and minimum throughput delay for voice application on a per channel basis.

The backplane interface can operate at 2.048, 4.096 or 8.192 Mb/s, arranged in 125µs wide frames that contain 32, 64 or 128 channels, respectively. A built-in rate conversion circuit allows users to interface between backplane interface and the local interface which operates at 2.048 Mb/s or 8.192 Mb/s.

By using Mitel's message mode capability, the microprocessor can access input and output time-slots on a per channel basis. This feature is useful for transferring control and status information for external circuits or other ST-Bus devices.

The frame offset calibration function allows users to measure the frame offset delay for streams STio0 to STio23. The offset calibration is activated by a frame evaluation bit in the frame evaluation register. The evaluation result is stored in the frame evaluation registers and can be used to program the input offset delay for individual streams using internal frame input offset registers.

## 2.0 Functional Description

A functional Block Diagram of the MT90863 is shown in Figure 1. One end of the MT90863 is used to interface with backplane applications, such as HMVIP or H.100 environments, while the other end supports the local switching environments.

## 2.1 Frame Alignment Timing

The Device Mode Selection (DMS) <u>regis</u>ter allows users to select three different frame <u>alignment timing modes</u>. In ST-BUS modes, the master clock (C16i) is always at 16.384 MHz. The frame pulse (F0i) input accepts a negative frame pulse at 8kHz. The frame pulse goes low <u>at the frame boundary for 61ns</u>. The frame pulse output F0o provides a 244ns wide negative frame pulse and the C4o output provides a 4.094MHz clock. These two signals are used to support local switching applications. See Figure 4 for the ST-BUS timings.

In CT Bus mode, the  $\overline{\text{C4i}}/\text{C8i}$  pin accepts 8.192MHz clock for the CT Bus frame pulse alignment. The  $\overline{\text{F0i}}$  is the CT bus frame pulse input. The CT frame pulse goes low at the frame boundary for 122ns. See Figure 5 for the CT Bus timing.

In HMVIP mode, the  $\overline{C4i}/C8i$  pin accepts 4.096MHz clock for the HMVIP frame pulse alignment. The  $\overline{F0i}$  is the HMVIP frame pulse input. The HMVIP frame pulse goes low at the frame boundary for 244ns. See Figure 6 for the HMVIP timing.

Table 1 - describes the input timing requirements for ST-BUS, CT Bus and HMVIP modes.

## 3.0 Switching Configuration

The device has four operation modes for the backplane interface and three operation modes for the local interface. These modes can be programmed via the Device Mode Selection (DMS) register. Mode selections between the backplane and local interfaces are independent. See Table 2 and Table 3 for the selection of various operation modes via the programming of the DMS register.

#### 3.1 Backplane Interface

The backplane interface can be programmed to accept data streams of 2Mb/s, 4Mb/s or 8Mb/s. When 2Mb/s mode is enabled, STio0 to STio31 have a data rate of 2.048Mb/s. When 4Mb/s mode is enabled, STio0 to STio31 have a data rate of 4.096Mb/s. When 8Mb/s mode is enabled, STio0 to STio15 have a data rate of 8.192Mb/s. When HMVIP mode is enabled, STio0 to STio15 have a data rate of 2.048Mb/s and STio16 to STio23 have a data rate of 8.192Mb/s. Table 2 describes the data rates and mode selection for the backplane interface.

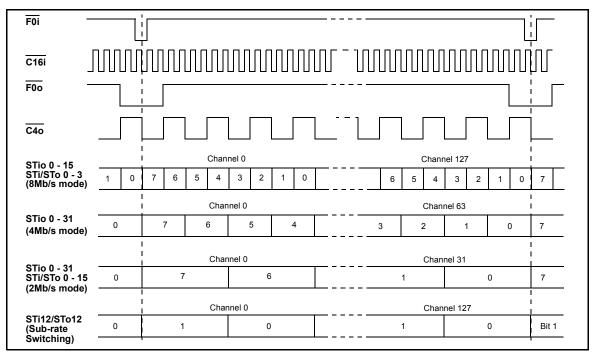


Figure 4 - ST-BUS Timing for 2, 4 and 8 Mb/s Data Streams

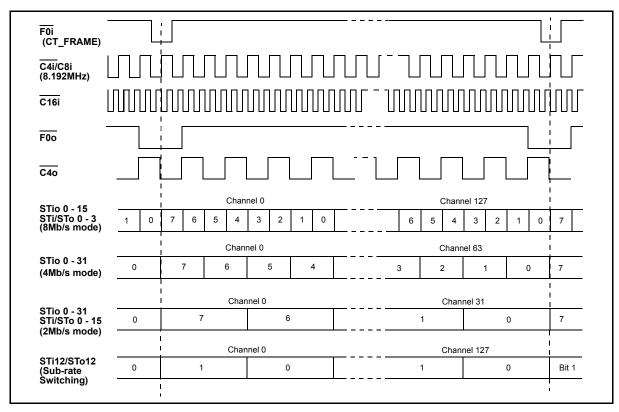


Figure 5 - CT Bus Mode Timing for 2, 4 and 8 Mb/s Data Streams

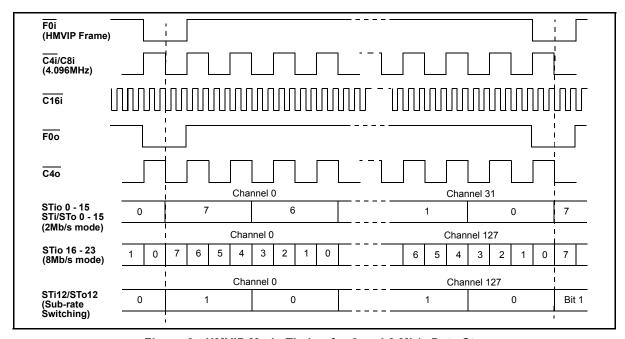


Figure 6 - HMVIP Mode Timing for 2 and 8 Mb/s Data Streams

#### 3.2 Local Interface

Three operation modes, 2Mb/s, 8Mb/s and Sub-rate Switching mode, can be selected for the local interface. When 2Mb/s mode is selected, STi0 to STi15 and STo0 to STo15 have a 2.048Mb/s data rate. When 8Mb/s mode is selected, STi0 to STi3 and STo0 to STo3 have an 8.192Mb/s data rate. When Sub-rate Switching mode is selected, STi0 to STi11 and STo0 to STo11 have 2.048Mb/s data with 64kb/s data channels and STi12 and STo12 have a 2.048Mb/s data rate with 16kb/s data channels. Table 3 describes the data rates and mode selection for the local interface.

## 3.3 Input Frame Offset Selection

Input frame offset selection allows the channel alignment of individual backplane input streams, that operate at 8.192Mb/s (STio0-23), to be shifted against the input frame pulse (Foi). This feature compensates for the variable path delays caused by serial backplanes of variable length. Such delays can be occur in large centralized and distributed switching systems.

Each backplane input stream can have its own delay offset value by programming the input delay offset registers (DOS0 to DOS5). Possible adjustment can range up to +4 master clock (C16i) periods forward with resolution of half master clock period. See Table 10 and Table 11, and Figure 9, Figure 9 - for frame input delay offset programming.

## 3.4 Output Advance Offset Selection

The MT90863 allows users to advance individual backplane output streams which operate at 8.192Mb/s (STio0-23) by half a master clock ( $\overline{\text{C16i}}$ ) cycle. This feature is useful in compensating for variable output delays caused by various output loading conditions. The frame output offset registers (FOR0 & FOR1) control the output offset delays for each backplane output stream via the OFn bit programming. Table 12 and Figure 10 detail frame output offset programming.

#### 3.5 Serial Input Frame Alignment Evaluation

The MT90863 provides the frame evaluation inputs, FEi0 to FEi23, to determine different data input delays with respect to the frame pulse  $\overline{\text{F0i}}$ . By using the frame evaluation input select bits (FE0 to FE4) of the frame alignment register (FAR), users can select one of the twenty-four frame evaluation inputs for the frame alignment measurement.

A measurement cycle is started by setting the start frame evaluation (SFE) bit low for at least one frame. Then the evaluation starts when the SFE bit in the Internal Mode Selection (IMS) register is changed from low to high. One frame later, the complete frame evaluation (CFE) bit of the frame alignment register changes from low to high to signal that a valid offset measurement is ready to be read from bits 0 to 9 of the FAR register. The SFE bit must be set to zero before a new measurement cycle is started.

Timing Signals	ST-BUS Mode	CT Bus Mode	HMVIP Mode				
F0i Width	61ns	122ns	244ns				
C4i/C8i	Not Required	8.192MHz	4.096MHz				
C16i	16.384MHz						
F0o Width	244ns						
C4o		4.096MHz					

Table 1 - Timing Signals Requirements for Various Operation Modes

DMS	Register	Bits	Modes		De alvalous Intenfess	Data Rate		
BMS2	BMS1	BMS0	iviodes	Modes Backplane Interface				
0	0	0	2Mb/s, ST-BUS Mode		STio0 - 31	2.048 Mb/s		
0	0	1	2Mb/s, CT Bus Mode		STio0 - 31	2.048 Mb/s		
0	1	0	4Mb/s, ST-BUS Mode		STio0 - 31	4.096 Mb/s		
0	1	1	4Mb/s, CT Bus Mode		STio0 - 31	4.096 Mb/s		
1	0	0	8Mb/s, ST-BUS Mode		STio0 - 15	8.192 Mb/s		
					STio16 - 31	Not available		
1	0	1	8Mb/s, CT Bus Mode		STio0 - 15	8.192 Mb/s		
					STio16 - 31	Not available		
1	1	0	HMVIP Mode		STio0 - 15	2.048 Mb/s		
					STio16 - 23	8.192 Mb/s		
					STio24 - 31	Not available		

Table 2 - Mode Selection for Backplane interface

DMS Reg	ister Bits		l a sal lutanta a	Data Data
LMS1	LMS0	Modes	Local Interface	Data Rate
0	0	2Mb/s Mode	STi0 - 15	2.048 Mb/s
			STo0 - 15	2.048 Mb/s
0	1	Sub-Rate	STi0 - 11	2.048 Mb/s
		Switching	STi12	Sub-rate Switching Input Stream at 2.048 Mb/s
		Mode	STi13 - 15	Not available
			STo0 - 11	2.048 Mb/s
			STo12	Sub-rate Switching Output Stream at 2.048Mb/s
			STo13 - 15	Not available
1	0	8Mb/s Mode	STi0 - 3	8.192 Mb/s
			STi4 - 15	Not available
			STo0 - 3	8.192 Mb/s
			STo4 - 15	Not available

Table 3 - Mode Selection for Local Interface

The falling edge of the frame measurement signal (FEi) is evaluated against the falling edge of the frame pulse  $(\overline{\text{F0i}})$ . Table 8 and Figure 8 describe the frame alignment register.

## 3.6 Memory Block Programming

The MT90863 has two connection memories: the backplane connection memory and the local connection memory. The local connection memory is partitioned into high and low parts. The IMS register provides users with the capability of initializing the local connection memory low and the backplane connection memory in two frames. Bit 11 to bit 13 of every backplane connection memory location will be programmed with the pattern stored in bit 7 to bit 9 of the IMS register. Bit 12 to 15 of every local connection memory low location will be programmed with the pattern stored in bits 3 to 6 of the IMS register.

The block programming mode is enabled by setting the memory block program (MBP) bit of the control register high. When the block programming enable (BPE) bit of the IMS register is set to high, the block programming data will be loaded into bits 11 to 13 of every backplane connection memory and bits 12 to 15 of every local connection memory low. The other connection memory bits are loaded with zeros. When the memory block programming is complete, the device resets the BPE bit to zero. See Figure 7 for the connection memory contents when the device is in block programming mode.

## 4.0 Delay Through the MT90863

The switching of information from the input serial streams to the output serial streams results in a throughput delay. The device can be programmed to perform time-slot interchange functions with different throughput delay capabilities on a per-channel basis. For voice applications, select variable throughput delay to ensure minimum delay between input and output data. In wideband data applications, select constant throughput delay to maintain the frame integrity of the information through the switch.

The delay through the device varies according to the type of throughput delay selected in the  $L\overline{V}/C$  and  $B\overline{V}/C$  bits of the local and backplane connection memory as described in Table 16 and Table 19.

## 4.1 Variable Delay Mode ( $L\overline{V}/C$ or $B\overline{V}/C$ bit = 0)

The delay in this mode is dependent only on the combination of source and destination channels and is independent of input and output streams.

## 4.2 Constant Delay Mode (LV/C bit or BV/C=1)

In this mode a multiple data memory buffer is used to maintain frame integrity in all switching configurations.

## 5.0 Microprocessor Interface

The MT90863 provides a parallel microprocessor interface for non-multiplexed bus structures. This interface is compatible with Motorola non-multiplexed buses. The required microprocessor signals are the 16-bit data bus (D0-D15), 8-bit address bus (A0-A7) and 4 control lines ( $\overline{CS}$ ,  $\overline{DS}$ , R/W and  $\overline{DTA}$ ). See Figure 16 - Figure 16 for Motorola non-multiplexed bus timing.

The MT90863 microprocessor port provides access to the internal registers, connection and data memories. All locations provide read/write access except for the Data Memory and the Data Read Register which are read only.

#### 5.1 Memory Mapping

The address bus on the microprocessor interface selects the internal registers and memories of the MT90863. If the A7 address input is low, then the registers are addressed by A6 to A0 as shown in Table 4.

If the A7 is high, the remaining address input lines are used to select the serial input or output data streams corresponding to the subsection of memory positions. For data memory reads, the serial inputs are selected. For connection memory writes, the serial outputs are selected.

The control, device mode selection and internal mode selection registers control all the major functions of the device. The device mode selection register and internal mode selection register should be programmed

immediately after system power-up to establish the desired switching configuration as explained in the Frame Alignment Timing and Switching Configurations sections.

The control register is used to control the switching operations in the MT90863. It selects the internal memory locations that specify the input and output channels selected for switching.

Control register data consists of: the memory block programming bit (MBP): the memory select bits (MS0-2); and, the stream address bits (STA0-4). The memory block programming bit allows users to program the entire connection memory block, (see Memory Block Programming section). The memory select bits control the selection of the connection memory or the data memory. The stream address bits define an internal memory subsections corresponding to serial input or serial output streams.

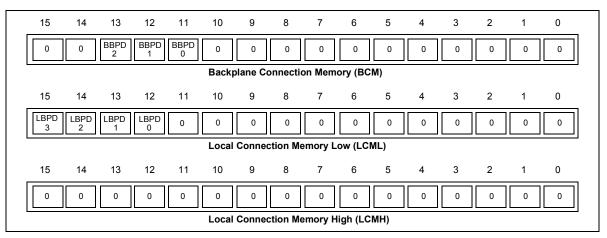


Figure 7 - Block Programming Data in the Connection Memories

A7 (Note 1)	A6	<b>A</b> 5	A4	А3	A2	A1	Α0	Location		
0	0	0	0	0	0	0	0	Control Register, CR		
0	0	0	0	0	0	0	1	Device Mode Selection Register, DMS		
0	0	0	0	0	0	1	0	Internal Mode Selection Register, IMS		
0	0	0	0	0	0	1	1	Frame Alignment Register, FAR		
0	0	0	0	0	1	0	0	Input Offset Selection Register 0, DOS0		
0	0	0	0	0	1	0	1	Input Offset Selection Register 1, DOS1		
0	0	0	0	0	1	1	0	Input Offset Selection Register 2, DOS2		
0	0	0	0	0	1	1	1	Input Offset Selection Register 3, DOS3		
0	0	0	0	1	0	0	0	Input Offset Selection Register 4, DOS4		
0	0	0	0	1	0	0	1	Input Offset Selection Register 5, DOS5		
0	0	0	0	1	0	1	0	Frame Output Offset Register, FOR0		
0	0	0	0	1	0	1	1	Frame Output Offset Register, FOR1		
0	0	0	0	1	1	0	0	Address Buffer Register, ABR		

Table 4 - Address Memory Map

A7 (Note 1)	A6	<b>A</b> 5	A4	А3	A2	<b>A</b> 1	Α0	Location
0	0	0	0	1	1	0	1	Data Write Register, DWR
0	0	0	0	1	1	1	0	Data Read Register, DRR
1 1 1 1	0 0 0	0 0 0	0 0 1	0 0 1	0 0 1	0 0 1	0 1	Ch 0 Ch 1 Ch 30 Ch 31 (Note 2)
1	0	0	1	1	1	1	1	Cit 31 (Note 2)
1 1	0 0	1 1	0 0 .	0 0 .	0 0 .	0 0 .	0 1 .	Ch 32 Ch 33 Ch 126
1	1 1	1 1	1 1	1 1	1 1	1 1	0 1	Ch 127 (Note 3)

#### Notae:

- 1. Bit A7 must be high for access to data and connection memory positions. Bit A7 must be low for access to registers.
- 2. Channels 0 to 31 are used when serial stream is at 2Mb/s.3. Channels 0 to 127 are used when serial stream is at 8Mb/s

Table 4 - Address Memory Map (continued)

The data in the DMS register consists of the local and backplane mode selection bits (LMS0-1 and BMS0-2) to enable various switching modes for local and backplane interfaces respectively.

The data in the IMS register consists of block programming bits (LBPD0-3 and BBPD0-2), block programming enable bit (BPE), output standby bit (OSB) and start frame evaluation bit (SFE). The block programming enable bit allows users to program the entire backplane and local connection memories, (see Memory Block Programming section). If the ODE pin is low, the OSB bit enables (if high) or disables (if low) all ST-BUS output drivers. If the ODE pin is high, the contents of the OSB bit is ignored and all ST-BUS output drivers are enabled.

See Table 5 for the output high impedance control.

## 5.2 Address Buffer Mode

The implementation of the address buffer, data read and data write registers allows faster memory read/write operation for the microprocessor port. See Table 6 and following for bit assignments.

The address buffer mode is controlled by the AB bit in the control register. The targeted memory for data read/write is selected by the MS0-2 bits in the control register.

The data write register (DWR) contains the data to be transferred to the memory. The data read register (DRR) contains the data transferred from the memory.

The address buffer register (ABR) allow users to specify the read or write address by programming the stream address bits (SA0-4) and the channel address bits (CA0-6). Data transfer from/to the memory is controlled by the read/write select bits (RS, WS). The complete data access (CDA) bit indicates the completion of data transfer between the memory and DWR or DRR register.

## 5.3 Write Operation Using Address Buffer Mode

Enable the address buffer mode by setting the AB bit from low to high. Program the DWR register with data to be transferred to memory. Load the ABR register with proper channel and stream information. Change the WS bit in the ABR register from low to high to initiate the data transfer from the DWR register to the memory. After several master clock cycles, the CDA bit in the ABR register changes from low to high to signal the completion of data transfer and resets the WS bit to low. Repeat the above steps for subsequent memory write operations. Disable the address buffer write operation by setting the AB bit to low.

## 5.4 Read Operation Using Address Buffer Mode

Enable the address buffer mode by setting the AB bit from low to high. Program the ABR register with proper channel and stream information. Change the RS bit in the ABR register from low to high to initiate the data transfer from the memory to the DRR register. After several master clock cycles, the CDA bit in the ABR register changes from low to high to signal the completion of data transfer and resets the RS bit to low. Read the DRR register to obtain the data transferred from the memory. Repeat the above steps for subsequent memory read operations. Disable the address buffer read operation by setting the AB bit to low.

## 5.5 Backplane Connection Memory Control

The backplane connection memory controls the switching configuration of the backplane interface. Locations in the backplane connection memory are associated with particular STio output streams.

The  $B\overline{V}/C$  (Variable/Constant Delay) bit of each backplane connection memory location allows the per-channel selection between variable and constant throughput delay modes for all STio channels.

In message mode, the message channel (BMC) bit of the backplane connection memory enables (if high) an associated STio output channel. If the BMC bit is low, the contents of the backplane connection memory stream address bit (BSAB) and channel address bit (BCAB) defines the source information (stream and channel) of the time-slot that will be switched to the STio streams. When message mode is enabled, only the lower half (8 least significant bits) of the backplane connection memory is transferred to the STio pins.

ODE pin	OSB bit in IMS register	DC bit in Backplane CM	STio0-31 Output Driver Status	OE bit in Local CM	STo0-15 Output Driver Status
Don't Care	Don't Care	0	Per Channel High Impedance	0	Per Channel High Impedance
0	0	Don't care	High Impedance	Don't care	High Impedance
0	1	1	Enable	1	Enable
1	Don't care	1	Enable	1	Enable

Table 5 - Output High Impedance Control

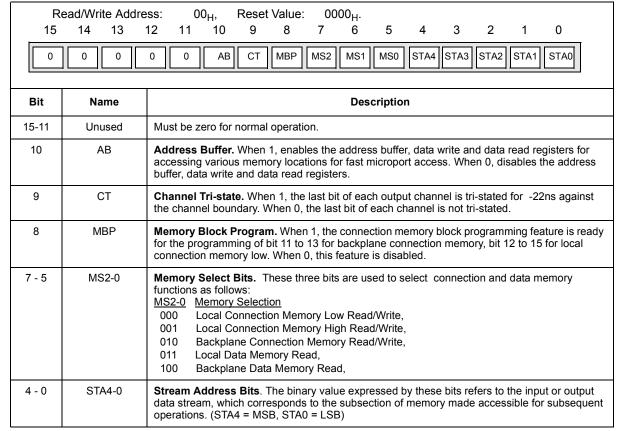


Table 6 - Control (CR) Register Bits

R 15	Read/Write Address: 01 <sub>H</sub> , Reset Value: 0000 <sub>H</sub> . 15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0											
0 0 0 0 0 0 0 0 0 LMS1 LMS0 BMS2 BMS1 BMS0												
Bit	Name	Description										
15 - 5	unused	Reserved										
4 - 3	LMS	Local Mode Selection Bit. The binary value expressed by these bits refers to the following backplane interface switching modes:  LMS1-0 Local Switching Mode 00 2Mb/s ST-BUS Mode 01 2Mb/s Sub-rate Switching Mode 10 8Mb/s ST-Bus Mode										

Table 7 - Device Mode Selection (DMS) Register Bits

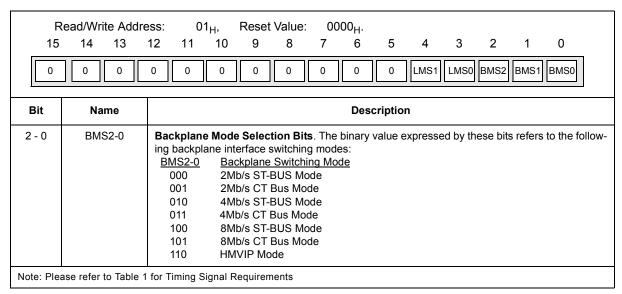


Table 7 - Device Mode Selection (DMS) Register Bits (continued)

## 5.6 Local Connection Memory Control

The local connection memory controls the local interface switching configuration. Local connection memory is split into high and low parts. Locations in local connection memory are associated with particular STo output streams.

The L/B (Local/Backplane Select) bit of each local connection memory location allows per-channel selection of source streams from local or backplane interface.

The  $L\overline{V}/C$  (Variable/Constant Delay) bit of each local connection memory location allows the per-channel selection between variable and constant throughput delay modes for all STo channels.

In message mode, the local connection memory message channel (LMC) bit enables (if high) an associated STo output channel. If the LMC bit is low, the contents of the stream address bit (LSAB) and the channel address bit (LCAB) of the local connection memory defines the source information (stream and channel) of the time-slot that will be switched to the STo streams. When message mode is enabled, only the lower half (8 least significant bits) of the local connection memory low bits are transferred to the STo pins.

When sub-rate switching is enabled, the LSR0-1 bits in the local connection memory high define which bit position contains the sub-rate data.

## 5.7 DTA Data Transfer Acknowledgment Pin

The DTA pin is driven LOW by internal logic to indicate (to the CPU) that a data bus transfer is complete. When the bus cycle ends, this pin drives HIGH and then switches to the high-impedance state. If a short or signal contention prevents the DTA pin from reaching a valid logic HIGH, it will continue to drive for approximately 15nsec before switching to the high-impedance state.

#### 6.0 Initialization of the MT90863

During power up, the  $\overline{TRST}$  pin should be pulsed low, or held low continuously, to ensure that the MT90863 is in the normal operation mode. A  $5K\Omega$  pull-down resistor can be connected to this pin so that the device will not enter the JTAG test mode during power up.

After power up, the contents of the connection memory can be in any state. The ODE pin should be held low after power up to keep all serial outputs in a high impedance state until the microprocessor has initialized the switching matrix. This procedure prevents two serial outputs from driving the same stream simultaneously.

During the microprocessor initialization routine, the microprocessor should program the desired active paths through the switch. The memory block programming feature can also be used to quickly initialize the DC and OE bit in the backplane and local connection memory respectively.

When this process is complete, the microprocessor controlling the matrices can either bring the ODE pin high or enable the OSB bit in IMS register to relinquish the high impedance state control.

	Read/Write Ad Reset Value:	ress: 02 <sub>H</sub> , 0000 <sub>H</sub> .
15	5 14 13	12 11 10 9 8 7 6 5 4 3 2 1 0
0	0 0	0 0 BBPD BBPD BBPD LBPD LBPD LBPD LBPD D BPE OSB SFE
Bit	Name	Description
15-10	Unused	Must be zero for normal operation.
9-7	BBPD2-0	Backplane Block Programming Data. These bits carry the value to be loaded into the backplane connection memory block when the Memory Block Programming feature is active. After the MBP bit in the control register is set to 1 and the BPE bit is set to 1, the contents of bits BBPD2-0 are loaded into the bit 13 to bit 11 position of the backplane connection memory. Bit 15, bit 14 and bit 10 to bit 0 of the backplane connection memory are zeroed.
6-3	LBPD3-0	Local Block Programming Data. These bits carry the value to be loaded into the local connection memory block when the Memory Block Programming feature is active. After the MBP bit in the control register is set to 1 and the BPE bit is set to 1, the contents of bits LBPD3-0 are loaded into the bit 15 to bit 12 position of the local connection memory. Bit 11 to bit 0 of the local connection memory low are zeroed. Bit 15 to bit 0 of local connection memory high are zeroed.
2	BPE	Begin Block Programming Enable. A zero to one transition of this bit enables the memory block programming function. The BPE, BBPD2-0 and LBPD3-0 bits in the IMS register must be defined in the same write operation. Once the BPE bit is set high, the device requires two frames to complete the block programming. After the programming function has finished, the BPE bit returns to zero to indicate the operation is completed. When the BPE = 1, the BPE or MBP can be set to 0 to abort the programming operation.  When BPE = 1, the other bits in the IMS register must not be changed for two frames to ensure proper operation.

Table 8 - Internal Mode Selection (IMS) Register Bits

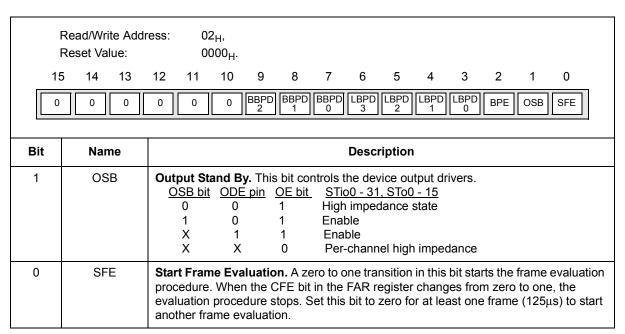


Table 8 - Internal Mode Selection (IMS) Register Bits (continued)

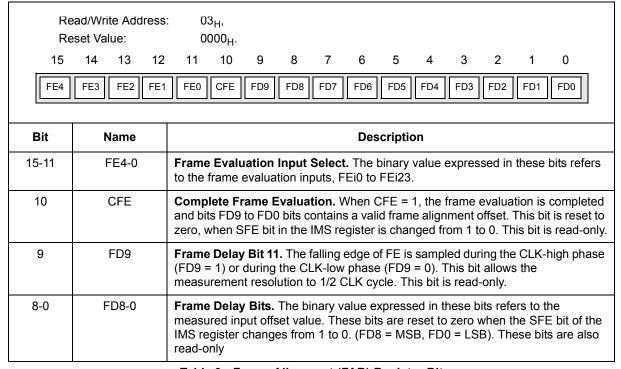


Table 9 - Frame Alignment (FAR) Register Bit

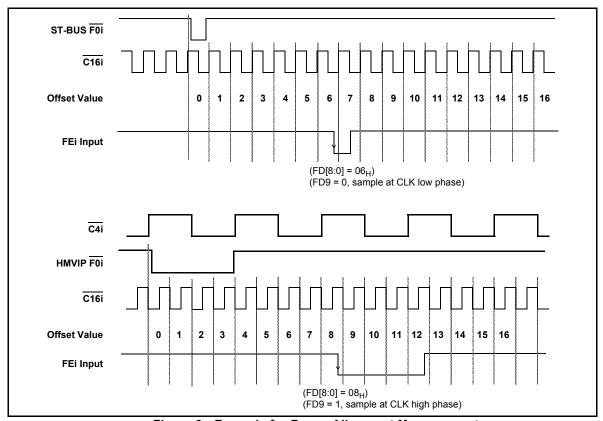


Figure 8 - Example for Frame Alignment Measurement

	Read	d/Write	Addr	ess:	• • •			gister,									
								gister,									
					06 <sub>H</sub> for DOS2 register,												
					07 <sub>H</sub> for DOS3 register,												
				08 <sub>H</sub> for DOS4 register,													
	Rese	et value	۵.		09 <sub>H</sub> for DOS5 register, 0000 <sub>H</sub> for all DOS registers.												
	15		*														
	15	14		1													,
	IF32	IF31	IF30	DLE3	IF22	IF21	IF20	DLE2	IF12	IF11	IF10	DLE1	IF02	IF01	IF00	DLE0	
								00S0 r	egiste	r							
	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	_
	IF72	IF71	IF70	DLE7	IF62	IF61	IF60	DLE6	IF52	IF51	IF50	DLE5	IF42	IF41	IF40	DLE4	
								00S1 r	egiste	r							1
	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	IF112	IF111	IF110	DLE11	IF102	IF101	IF100	DLE10	IF92	IF91	IF90	DLE9	IF82	IF81	IF80	DLE8	
	<u> </u>							00S2 r	ogisto								1
	15	14	13	12	11	10	9	8	egiste 7	6	5	4	3	2	1	0	
	IF152	IF151	IF150	DLE15	IF142	IF141	IF140	DLE14	IF132	IF131	IF130	DLE13	IF122	IF121	IF120	DLE12	
Ŀ								0000 =		<u> </u>							1
	15	14	13	12	11	10	9	0 <b>OS3</b> r	egiste 7	e <b>r</b> 6	5	4	3	2	1	0	
	IF192	IF191	IF190	DLE19	IF182	IF181	IF180	DLE18	IF172	IF171	IF170	DLE17	IF162	IF161	IF160	DLE16	
L							Г	00S4 r	ogisto	<u> </u>							ı
	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	IF232	IF231	IF230	DLE23	IF222	IF221	IF220	DLE22	IF212	IF211	IF210	DLE21	IF202	IF201	IF200	DLE20	
L				_      <u> </u>			Г	00S5 r	eniste	r							ı
	Nar (Not								C	escrip	otion						
IF	n2, IFr	1, IFn	0	Input Offset Bits 2,1 & 0. These three bits define how long the serial interface receiver													
takes to recognize and store bit 0 from the STio pin: i.e., to start a new fram																	
frame offset can be selected to +4 clock periods from the point where pulse input signal is applied to the $\overline{\text{F0i}}$ inputs of the device. Figure 9 -											CAIC	111011101	110				
	DLI	En .		Data L			•••			•							
	DLI	<b>∟</b> 11		ST-BU			LEn =	0, if clo	ck risi	ng edg	e is at	the 3/-	4 point	of the	bit cel	II.	
								1, if clo									

Table 10 - Frame Delay Offset (DOS) Register Bits

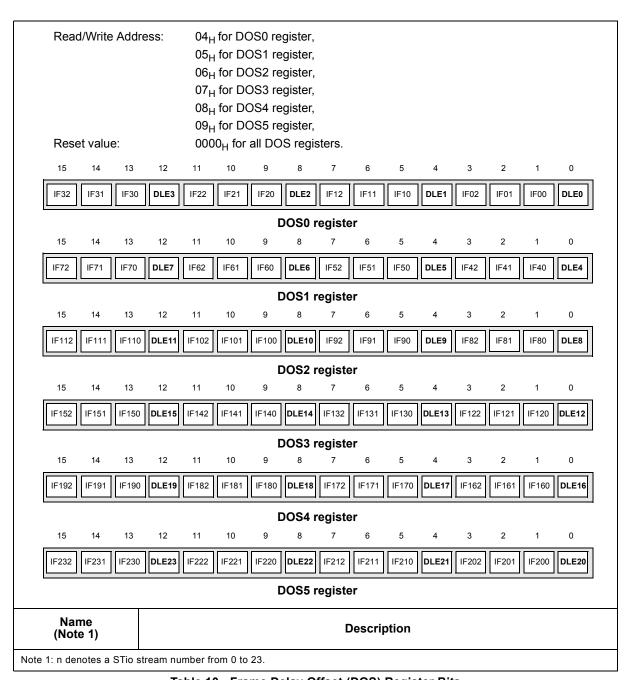


Table 10 - Frame Delay Offset (DOS) Register Bits

Input Stream Offset	Measurement Result from Frame Delay Bits				Corresponding Offset Bits			
Offset	FD9	FD2	FD1	FD0	IFn2	IFn1	IFn0	DLEn
No clock period shift (Default)	1	0	0	0	0	0	0	0
+ 0.5 clock period shift	0	0	0	0	0	0	0	1
+1.0 clock period shift	1	0	0	1	0	0	1	0
+1.5 clock period shift	0	0	0	1	0	0	1	1
+2.0 clock period shift	1	0	1	0	0	1	0	0
+2.5 clock period shift	0	0	1	0	0	1	0	1
+3.0 clock period shift	1	0	1	1	0	1	1	0
+3.5 clock period shift	0	0	1	1	0	1	1	1
+4.0 clock period shift	1	1	0	0	1	0	0	0
+4.5 clock period shift	0	1	0	0	1	0	0	1

Table 11 - Offset Bits (IFn2, IFn1, IFn0, DLEn) & Input Offset Bits (FD9, FD2-0)

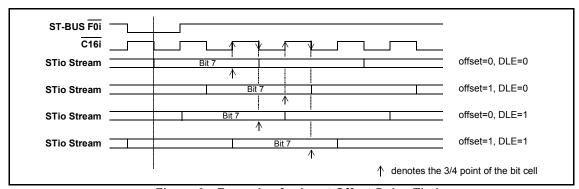


Figure 9 - Examples for Input Offset Delay Timing

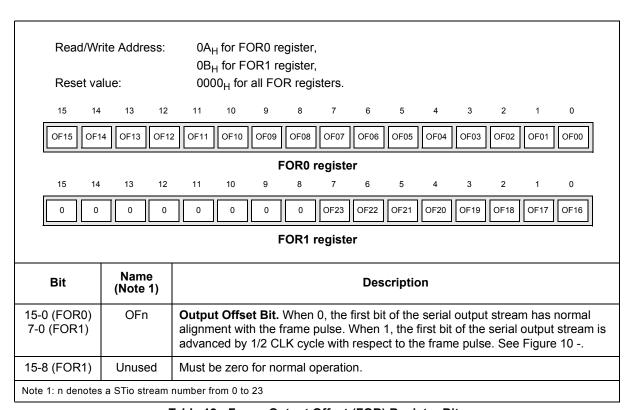


Table 12 - Frame Output Offset (FOR) Register Bits

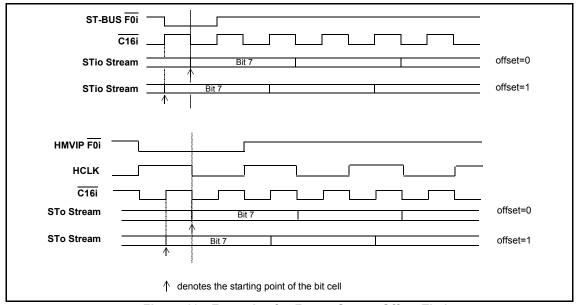


Figure 10 - Examples for Frame Output Offset Timing

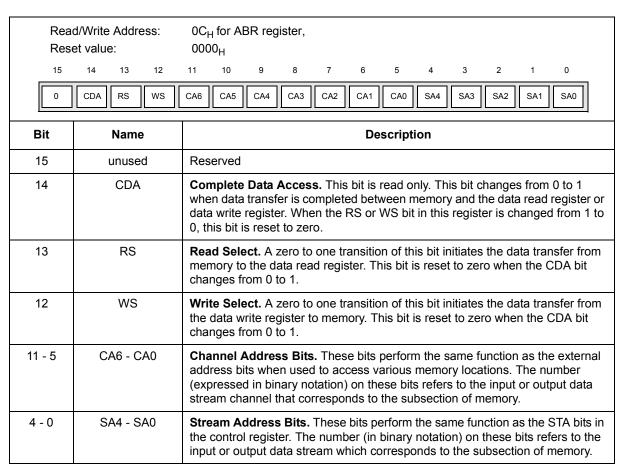


Table 13 - Address Buffer (ABR) Register Bits

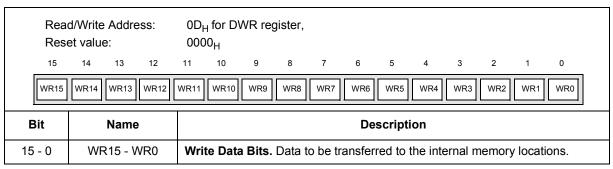


Table 14 - Data Write (DWR) Register Bits

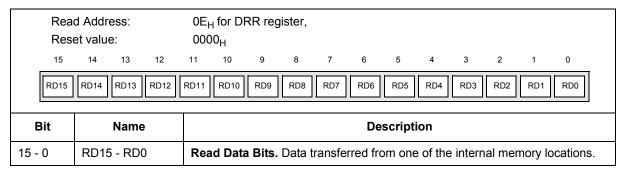


Table 15 - Data Read (DRR) Register Bits

15		11 10 9 8 7 6 5 4 3 2 1 0  OC BSAB BSAB BSAB BSAB BSAB BCAB BCAB BCA				
Bit	Name	Description				
15,14	Unused	Must be zero for normal operation.				
13	B <del>V</del> /C	Variable /Constant Throughput Delay. This bit is used to select either variable (low) or constant delay (high) modes on a per-channel basis for the local interface streams.				
12	ВМС	Message Channel. When 1, the backplane connection memory contents are output on the corresponding output channel and stream. Only the lower byte (bit 7 - bit 0) will be output to the backplane interface STio pins. When 0, the local data memory address of the switched STi input channel and stream is loaded into the backplane connection memory.				
11	DC	<b>Directional Control.</b> This bit enables the STio pindrivers on a per-channel basis. When 1, the STio output driver functions normally. When 0, the STio output driver is in a high-impedance state.				
10-7 (Note 1)	BSAB3-0	Source Stream Address Bits. The binary value is the number of the data stream for the source of the connection.				
6-0 (Note 1)	BCAB6-0	Source Channel Address Bits. The binary value identifies the channel for the connection source.				

Note 1: If bit 12 (BMC) of the corresponding backplane connection memory location is 1 (device in message mode), then these entire 8 bits (BSAB0, BCAB6 - BCAB0) are output on the output channel and stream associated with this location.

**Table 16 - Blackplane Connection Memory Bits** 

Data Rate	BSAB3 to BSAB0 Bits Used to Determine the Source Stream of the connection
2.048 Mb/s	STi0 to STi15
8.192 Mb/s	STi0 to STi3
2.048 Mb/s Sub-rate Switching	STi0 to STi12

Table 17 - BSAB Bits Programming for Different Local Interface mode

Data Rate	BCAB Bits Used to Determine the Source Channel of the Connection
2.048 Mb/s	BCAB4 to BCAB0 (32 channel/frame)
8.192 Mb/s	BCAB6 to BCAB0 (128 channel/frame)
2.048 Mb/s Sub-rate Switching	BCAB4 to BCAB0 (32 channel/frame) BCAB6 to BCAB0 (128 channel/frame)

Table 18 - BCAB Bits Programming for Different Data Rates

15	14 13 12	11 10 9 8 7 6 5 4 3 2 1 0				
L/B	BV/C BMC OE	SAB LSAB LSAB LSAB LSAB LSAB LSAB LSAB L				
Bit	Name	Description				
15	L/B	Local/Backplane Select When 1, the output channel of STo0-15 comes from STi0-15 (local) When 0, the output channel of STo0-15 comes from: STio0-31 (backplane, 2Mb/s mode) STio0-31 (backplane, 4Mb/s mode) STio0-15 (blackplane, 8Mb/s mode) STio0-23 (blackplane, HMVIP mode)				
14	L <del>∇</del> /C	Variable /Constant Throughput Delay. This bit is used to select either variable (low) or constant delay (high) modes on a per-channel basis for the source streams.				
13	LMC	<b>Message Channel.</b> When 1, the contents of the local connection memory are output on the corresponding output channel and stream. Only the lower byte (bit 7 - bit 0) will be output to the STo pins of the local interface. When 0, the backplane or local data memory address of the switched input channel and stream is loaded into the local connection memory.				
12	OE	Output Enable. This bit enables the drivers of STo pins on a per-channel basis. When 1, the STo output driver functions normally. When 0, the STo output driver is in a high-impedance state.				

**Table 19 - Local Connection Memory Low Bits** 

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
L/B	BV/C	ВМС	OE	LSAB 4	LSAB 3	LSAB 2	LSAB 1	LSAB 0	LCAB 6	LCAB 5	LCAB 4	LCAB 3	LCAB 2	LCAB 1	LCAB 0
Bit		Nan	ne						D	escript	ion				
11-7 (Note 1)		LSAB	4-0					ess Bi nection		e binar	y value	e ident	ifies the	e data	stream for
6-0 (Note 1)		LCAB	6-0					Iress E		he bina	ıry val	ue ider	ntifies t	he cha	innel for

Note 1: If bit 12 (LMC) of the corresponding local connection memory location is 1 (device in message mode), then these entire 8 bits (LSAB0, LCAB6 - LCAB0) are output on the output channel and stream associated with this location.

**Table 19 - Local Connection Memory Low Bits (continued)** 

Data Rate	LSAB3 to LSAB0 Bits Used to Determine the Source Stream of the Connection
2.048 Mb/s	STio0 to STio31 or STi0 to STi15
4.096 Mb/s	STio0 to STio31
8.192 Mb/s	STio0 to STio15 or STi0 to STi3
HMVIP	STio0 to STio23
2.048 Mb/s Sub-rate Switching	STi0 to STi12

Table 20 - LSAB Bits Programming for Different Local Interface Modes

Data Rate	LCAB Bits Used to Determine the Source Channel of the Connection
2.048 Mb/s	LCAB4 to LCAB0 (32 channel/frame)
4.096 Mb/s	LCAB5 to LCAB0 (64 channel/frame)
8.192 Mb/s	LCAB6 to LCAB0 (128 channel/frame)
HMVIP	LCAB4 to LCAB0 (32 channel/frame) LCAB6 to LCAB0 (128 channel/frame)
2.048 Mb/s Sub-rate Switching	LCAB4 to LCAB0 (32 channel/frame) LCAB6 to LCAB0 (128 channel/frame)

Table 21 - LCAB Bits Programming for Different Data Rates

MT90863

15	14 13 12	1 10 9 8 7 6 5 4 3 2 1 0 0 0 0 0 0 0 0 0 LSR1 LSR0
Bit	Name	Description
15-2 (Note1)	Unused	Must be zero for normal operation.
1,0 (Note1)	LSR1, LSR0	Local Sub-rate Switching Bit  When 11 Bit7-6 will be the output of the subrate switching stream  When 10 Bit5-4 will be the output of the subrate switching stream  When 01 Bit3-2 will be the output of the subrate switching stream  When 00 Bit1-0 will be the output of the subrate switching stream

Note 1: If bit 12 (LMC) of the corresponding local connection memory location is 1 (device in message mode), then these entire 8 bits (Bit7-0) are output on the output channel and stream associated with this location.

**Table 22 - Local Connection Memory High Bits** 

## 7.0 JTAG Support

The MT90863 JTAG interface conforms to the Boundary-Scan IEEE1149.1 standard. This stan-dard specifies a design-for-testability technique called Boundary-Scan Test (BST). The operation of the boundary-scan circuitry is controlled by an external Test Access Port (TAP) Controller.

## 7.1 Test Access Port (TAP)

The Test Access Port (TAP) accesses the MT90863 test functions. It consists of three input pins and one output pin as follows:

#### Test Clock Input (TCK)

TCK provides the clock for the test logic. The TCK does not interfere with any on-chip clock and thus remains independent. The TCK permits shifting of test data into or out of the Boundary-Scan register cells concurrently with the operation of the device and without interfering with the on-chip logic.

#### Test Mode Select Input (TMS)

The TAP Controller uses the logic signals received at the TMS input to control test operations. The TMS signals are sampled at the rising edge of the TCK pulse. This pin is internally pulled to Vdd when it is not driven from an external source.

#### Test Data Input (TDi)

Serial input data applied to this port is fed either into the instruction register or into a test data register, depending on the sequence previously applied to the TMS input. Both registers are described in a subsequent section. The received input data is sampled at the rising edge of TCK pulses. This pin is internally pulled to Vdd when it is not driven from an external source.

#### Test Data Output (TDo)

Depending on the sequence previously applied to the TMS input, the contents of either the instruction register or data register are serially shifted out towards the TDo. The data out of the TDo is clocked on the falling edge of the TCK pulses. When no data is shifted through the boundary scan cells, the TDo driver is set to a high impedance state.

## Test Reset (TRST)

Reset the JTAG scan structure. This pin is internally pulled to VDD.

## 7.2 Instruction Register

The MT90863 uses the public instructions defined in the IEEE 1149.1 standard. The JTAG Interface contains a two-bit instruction register. Instructions are serially loaded into the instruction register from the TDi when the TAP Controller is in its shifted-IR state. These instructions are subsequently de-coded to achieve two basic functions: to select the test data register that may operate while the instruction is current; and, to define the serial test data register path that is used to shift data between TDi and DO during data register scan-ning.

## 7.3 Test Data Register

As specified in IEEE 1149.1, the MT90863 JTAG Interface contains three test data registers:

## · The Boundary-Scan Register

The Boundary-Scan register consists of a series of Boundary-Scan cells arranged to form a scan path around the boundary of the MT90863 core logic.

#### · The Bypass Register

The Bypass register is a single stage shift register that provides a one-bit path from TDi to its TDo.

## The Device Identification Register

The device identification register is a 32-bit register. The register contents are:

The LSB bit in the device identification register is the first bit clock out.

The MT90863 scan register contains 212 bits. Bit 0 in Table 23 Boundary Scan Register is the first bit clocked out. All tri-state enable bits are active high.

	Boundary Scan Bit 0 to Bit 213							
Device Pin	Tri-state Control	Output Scan Cell	Input Scan Cell					
A0 A1 A2 A3 A4 A5 A6 A7 DS R/W CS			0 1 2 3 4 5 6 7 8 9					

Table 23 - Boundary Scan Register Bits

	Bounda	ry Scan Bit 0 t	to Bit 213
Device Pin	Tri-state Control	Output Scan Cell	Input Scan Cell
D0 D1 D2 D3 D4 D5 D6 D7 D8 D9 D10 D11 D12 D13 D14 D15	11 14 17 20 23 26 29 32 35 38 41 44 47 50 53 56	12 15 18 21 24 27 30 33 36 39 42 45 48 51 54	13 16 19 22 25 28 31 34 37 40 43 46 49 52 55 58
DTA		59	
STI0 STI1 STI2 STI3 STI4 STI5 STI6 STI7			60 61 62 63 64 65 66
STi8 STi9 STi10 STi11 STi12 STi13 STi14 STi15 ODE			68 69 70 71 72 73 74 75 76
ST00 ST01 ST02 ST03 ST04 ST05 ST06 ST07 ST08 ST09 ST010 ST011 ST012 ST013 ST014 ST015	77 79 81 83 85 87 89 91 93 95 97 99 101 103 105	78 80 82 84 86 88 90 92 94 96 98 100 102 104 106 108	
C16i F0i C4i/C8i F0o C4o	112 114	113 115	109 110 111

Table 23 - Boundary Scan Register Bits (continued)

	Boundary Scan Bit 0 to Bit 213						
Device Pin	Tri-state	Output	Input				
	Control	Scan Cell	Scan Cell				
STio0/FE0	116	117	118				
STio1/FE1	119	120	121				
STio2/FE2	122	123	124				
STio3/FE3	125	126	127				
STio4/FE4	128	129	130				
STio5/FE5	131	132	133				
STio6/FE6	134	135	136				
STio7/FE7	137	138	139				
STio8/FE8 STio9/FE9 STio10/FE10 STio11/FE11 STio12/FE12 STio13/FE13 STio14/FE14 STio15/FE15	140 143 146 149 152 155 158 161	141 144 147 150 153 156 159	142 145 148 151 154 157 160 163				
STio16/FE16	164	165	166				
STio17/FE17	167	168	169				
STio18/FE18	170	171	172				
STio19/FE19	173	174	175				
STio20/FE20	176	177	178				
STio21/FE21	179	180	181				
STio22/FE22	182	183	184				
STio23/FE23	185	186	187				
STio24 STio25 STio26 STio27 STio28 STio29 STio30 <u>STio31</u> RESET	188 191 194 197 200 203 206 209	189 192 195 198 201 204 207 210	190 193 196 199 202 205 208 211 212				

Table 23 - Boundary Scan Register Bits (continued)

MT90863

## **Absolute Maximum Ratings\***

	Parameter	Symbol	Min	Max	Units
1	Supply Voltage	$V_{DD}$	-0.5	5.0	V
2	Input Voltage	VI	-0.5	V <sub>DD</sub> +0.5	V
3	Output Voltage	V <sub>o</sub>	-0.5	V <sub>DD</sub> +0.5	V
4	Package power dissipation	$P_{D}$		2	W
5	Storage temperature	T <sub>S</sub>	- 55	+125	°C

<sup>\*</sup> Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.

## **Recommended Operating Conditions -** Voltages are with respect to ground (V<sub>ss</sub>) unless otherwise stated.

	Characteristics	Sym	Min	Тур	Max	Units	Test Conditions
1	Operating Temperature	T <sub>OP</sub>	-40		+85	°C	
2	Positive Supply	$V_{DD}$	3.0		3.6	V	
3	Input High Voltage	V <sub>IH</sub>	$0.7V_{DD}$		$V_{DD}$	V	
4	Input High Voltage on 5V Tolerant Inputs	V <sub>IH</sub>			5.5	V	
5	Input Low Voltage	V <sub>IL</sub>	V <sub>SS</sub>		$0.3V_{DD}$	٧	

# $\textbf{AC Electrical Characteristics -} \textit{Voltages are with respect to ground (V}_{ss}) \textit{ unless otherwise stated}.$

		Characteristics	Sym	Min	Тур	Max	Units	Test Conditions
1		Supply Current	I <sub>DD</sub>		52	85	mA	Output unloaded
2	Ţ	Input High Voltage	$V_{IH}$	0.7V <sub>DD</sub>			V	
3	N P	Input Low Voltage	$V_{IL}$			$0.3V_{DD}$	V	
4	U T S	Input Leakage (input pins) Input Leakage (bi-directional pins)	I <sub>IL</sub> I <sub>BL</sub>			10 50	μA μA	0≤ <v≤v<sub>DD See Note 1</v≤v<sub>
5		Input Pin Capacitance	CI			10	pF	
6	0	Output High Voltage	V <sub>OH</sub>	0.8V <sub>DD</sub>			V	I <sub>OH</sub> = 10mA
7	U T	Output Low Voltage	V <sub>OL</sub>			0.4	V	I <sub>OL</sub> = 10mA
8	P U T	High Impedance Leakage	l <sub>OZ</sub>			5	μΑ	0 < V < V <sub>DD</sub> See Note 1
9	S	Output Pin Capacitance	C <sub>O</sub>			10	pF	

Note

## **AC Electrical Characteristics - Timing Parameter Measurement Voltage Levels**

	Characteristics	Sym	Level	Units	Conditions
1	CMOS Threshold	V <sub>CT</sub>	0.5V <sub>DD</sub>	V	
2	Rise/Fall Threshold Voltage High	$V_{HM}$	0.7V <sub>DD</sub>	V	
3	Rise/Fall Threshold Voltage Low	$V_{LM}$	0.3V <sub>DD</sub>	V	

<sup>\*</sup> Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied

<sup>1.</sup> Maximum leakage on pins (output or I/O pins in high impedance state) is over an applied voltage (V)

## **AC Electrical Characteristics - Frame Pulse and CLK**

	Characteristic	Sym	Min	Тур	Max	Units	Notes
1	Frame pulse width	t <sub>FPW</sub>		60		ns	ST-BUS mode
2	Frame Pulse Setup time before C16i falling	t <sub>FPS</sub>		10		ns	
3	Frame Pulse Hold Time from C16i falling	t <sub>FPH</sub>		10		ns	
4	C16i Period	t <sub>CP</sub>		60		ns	
5	C16i Pulse Width High	t <sub>CH</sub>		30		ns	ST-BUS, CT Bus
6	C16i Pulse Width Low	t <sub>CL</sub>		30		ns	or HMVIP mode
7	Clock Rise/Fall Time	t <sub>r</sub> , t <sub>f</sub>		10		ns	
8	FPo Frame pulse output width	t <sub>FPOW</sub>		244		ns	
9	FPo Frame Pulse output setup time before C4o falling	t <sub>FPOS</sub>	10		150	ns	
10	FPo Frame Pulse output Hold Time from C4o falling	t <sub>FPOH</sub>	20	10	150	ns	
11	C4o Period	t <sub>C4OP</sub>		244		ns	
12	C4o Pulse Width High	t <sub>C40H</sub>		122		ns	
13	C4o Pulse Width Low	t <sub>C40L</sub>		122		ns	
14	CT frame pulse width	t <sub>CFPW</sub>		122		ns	CT Bus mode
15	CT Frame Pulse Setup Time before C8i rising	t <sub>CFPS</sub>	45		90	ns	
16	CT Frame Pulse Hold Time from C8i rising	t <sub>CFPH</sub>	45		90	ns	
17	C8i Period	t <sub>HCP</sub>		122		ns	
18	C8i Pulse Width High	t <sub>HCH</sub>		61		ns	
19	C8i Pulse Width Low	t <sub>HCL</sub>		61		ns	
20	HMVIP frame pulse width	t <sub>HFPW</sub>		244		ns	HMVIP mode
21	Frame Pulse Setup Time before C4i falling	t <sub>HFPS</sub>	50		150	ns	
22	Frame Pulse Hold Time from C4i falling	t <sub>HFPH</sub>	50		150	ns	
23	C4i Period	t <sub>HCP</sub>		244		ns	
24	C4i Pulse Width High	t <sub>HCH</sub>		122		ns	
25	C4i Pulse Width Low	t <sub>HCL</sub>		122		ns	
26	C4i/C8i Rise/Fall Time	$t_{Hr}$ , $t_{Hf}$		10		ns	HMVIP or CT Bus mode
27	Delay between falling edge of C4i/C8i and rising edge of C16i	t <sub>DIF</sub>	-10		10	ns	
28	Delay between falling edge of C16i and falling edge of C4o	t <sub>DC40</sub>	-10		10	ns	

## AC Electrical Characteristics - Serial Streams for Backplane and Local Interfaces

	Characteristic	Sym	Min	Тур	Max	Units	Test Conditions
1	STio/STi Set-up Time	t <sub>SIS</sub>	0			ns	
2	STio/STi Hold Time	t <sub>SIH</sub>	6			ns	
3	STo Delay - Active to Active	t <sub>SOD</sub>	5	16	32	ns	C <sub>L</sub> =200pF
4	STo delay - Active to High-Z - High-Z to Active	t <sub>ZD</sub>			35	ns	R <sub>L</sub> =1K, C <sub>L</sub> =200pF, See Note 1
5	Output Driver Enable (ODE) Delay	t <sub>ODE</sub>			35	ns	

Note:

<sup>1.</sup> High Impedance is measured by pulling to the appropriate rail with  $R_L$ , with timing corrected to cancel time taken to discharge  $C_L$ .

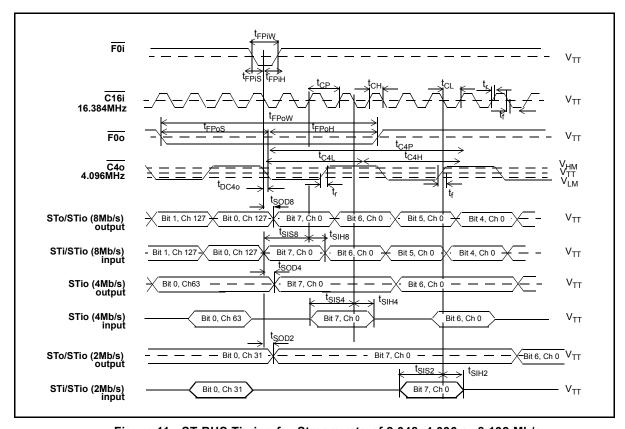


Figure 11 - ST-BUS Timing for Stream rate of 2.048, 4.096 or 8.192 Mb/s

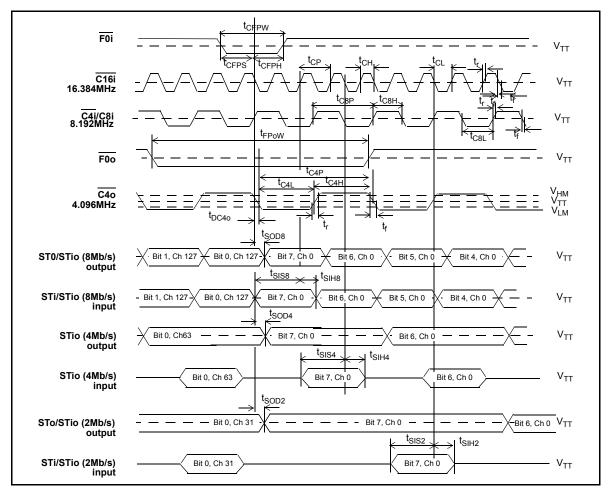


Figure 12 - CT Bus Timing for Stream rate of 2.048, 4.096 or 8.192 Mb/s

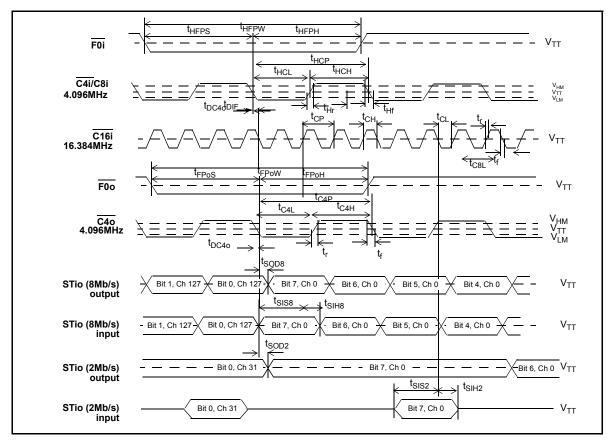


Figure 13 - HMVIP Bus Timing for Stream rate of 2.048 Mb/s or 8.192 Mb/s

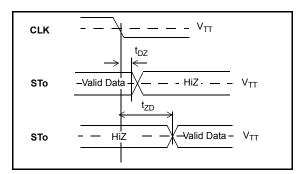


Figure 14 - Serial Output and External Control

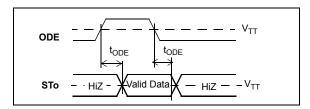


Figure 15 - Output Driver Enable (ODE)

# AC Electrical Characteristics - Motorola Non-Multiplexed Bus Mode

	Characteristics	Sym	Min	Тур	Max	Units	Test Conditions
1	CS setup from DS falling	t <sub>css</sub>		0		ns	
2	R/W setup from DS falling	t <sub>RWS</sub>		10		ns	
3	Address setup from DS falling	t <sub>ADS</sub>			5	ns	
4	CS hold after DS rising	t <sub>CSH</sub>		10		ns	
5	R/W hold after DS rising	t <sub>RWH</sub>		10		ns	
6	Address hold after DS rising	t <sub>ADH</sub>			6	ns	
7	Data setup from DTA low on read Reading registers Reading Memory	t <sub>DDR_REG</sub> t <sub>DDR_MEM</sub>			16 440	ns	C <sub>L</sub> =50pF
8	Data hold on read	t <sub>DHR</sub>			11	ns	C <sub>L</sub> =50pF, R <sub>L</sub> =1K Note 1
9	Data setup on write (fast write)	t <sub>DSW_REG</sub>			2	ns	
10	Valid data delay on write (slow write)	t <sub>SWD</sub>			150	ns	
11	Data hold on write	t <sub>DHW</sub>	5			ns	
12	Acknowledgment delay: Reading/writing registers Reading/writing memory	t <sub>AKD_REG</sub> t <sub>AKD_MEM</sub>			40 470	ns	C <sub>L</sub> =50pF
13	Acknowledgment hold time	t <sub>AKH</sub>			17	ns	C <sub>L</sub> =50pF, R <sub>L</sub> =1K, Note

Note:

<sup>1.</sup> High Impedance is measured by pulling to the appropriate rail with  $R_L$ , with timing corrected to cancel time taken to discharge  $C_L$ .

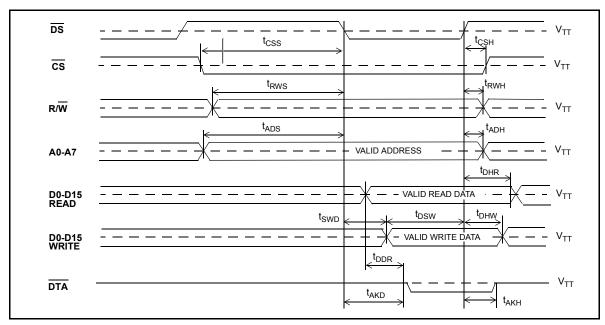
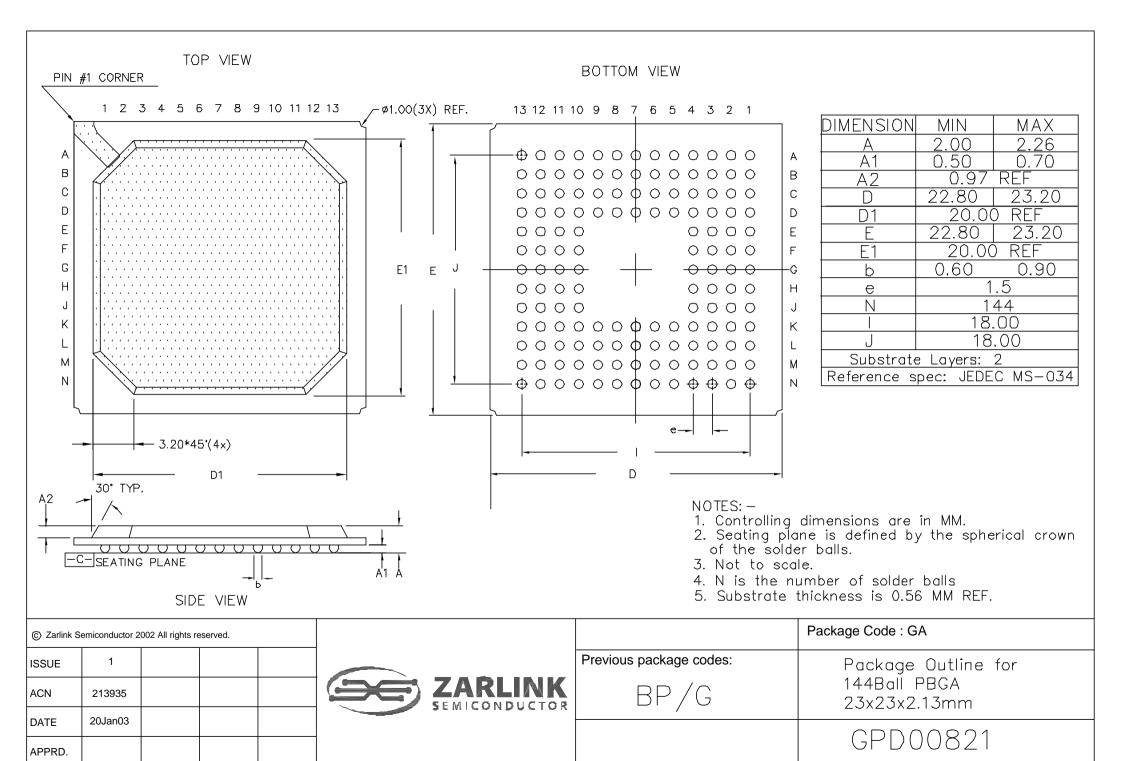
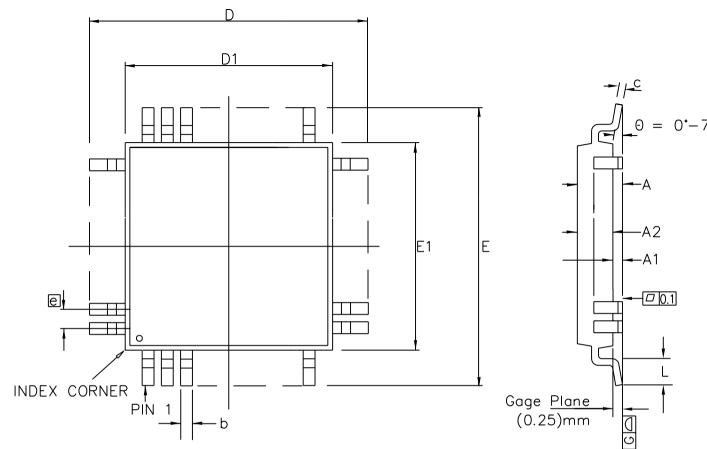


Figure 16 - Motorola Non-Multiplexed Bus Timing





	Control Di	mensions		Altern. Di	mensions	
Symbol	in milli	metres		in inches		
	MIN	MAX		MIN	MAX	
Α	_	4.10		_	0.161	
A1	0.25	0.50		0.010	0.020	
Α2	3.20	3.60		0.126	0.142	
D	31.20	BSC		1.228	BSC	
D1	28.00	BSC		1.102	BSC	
Ε	31.20	BSC		1.228 BSC		
E1	28.00	BSC		1.102	BSC	
L	0.73	1.03		0.029	0.041	
υ	0.80	BSC.		0.031	BSC.	
Ф	0.29	0.45		0.011	0.018	
U	0.11	0.23		0.004	0.009	
	Pin features					
Ν	128					
ND	32					
NE	32					
NOTE		S	QUAF	RE		
	<u> </u>					

Conforms to JEDEC MS-022 DB Iss. B

## Notes:

- 1. Pin 1 indicator may be a corner chamfer, dot or both.
- 2. Controlling dimensions are in millimeters.
- 3. The top package body size may be smaller than the bottom package body size by a max. of 0.15 mm.
- 4. Dimension D1 and E1 do not include mould protrusion.
- 5. Dimension b does not include dambar protrusion.
- 6. Coplanarity, measured at seating plane G, to be 0.10 mm max.

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APPRD.					



	Package Code QB
Previous package codes  GP / L	Package Outline for 128 lead MQFP (28 x 28 x 3.4mm) 3.2mm Footprint
	GPD00301



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